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Please note: As part of the Fairchild Semiconductor integration, some of the Fairchild orderable part numbers will need to change in order to meet ON Semiconductor's system requirements. Since the ON Semiconductor product management systems do not have the ability to manage part nomenclature that utilizes an underscore (\_), the underscore (\_) in the Fairchild part numbers will be changed to a dash (-). This document may contain device numbers with an underscore (\_). Please check the ON Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at <a href="https://www.onsemi.com">www.onsemi.com</a>. Please email any questions regarding the system integration to <a href="https://www.onsemi.com">Fairchild\_questions@onsemi.com</a>.

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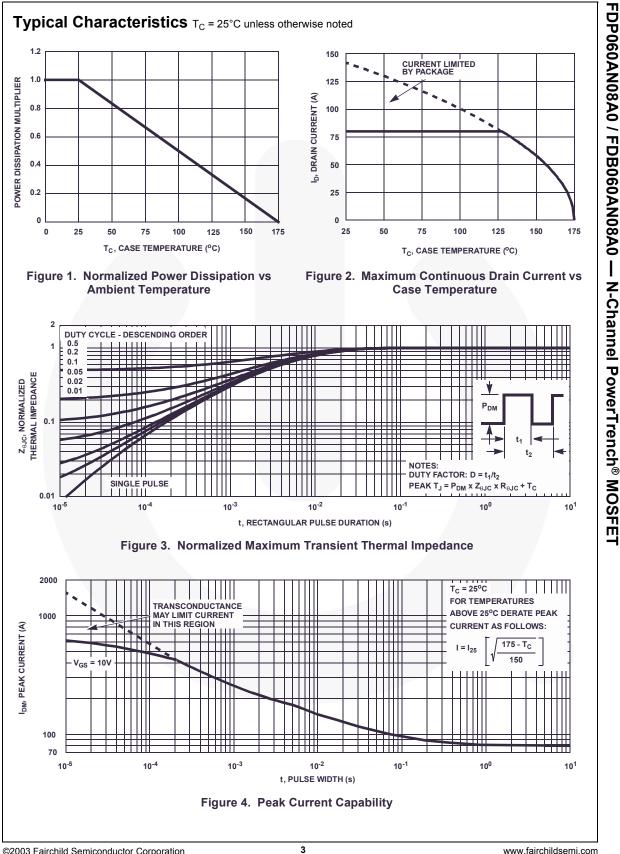
	NDUCTOR®		Octob	er 2013
	60AN08A0 / FDB060AN08A0			
N-Cha	Innel PowerTrench <sup>®</sup> MOSFET A, 6 m $\Omega$			
Features	Applications			
• R <sub>DS(on)</sub> = 4	4.8 m $\Omega$ (Typ.) @ V <sub>GS</sub> = 10 V, I <sub>D</sub> = 80 A • Synchronous Rectific	cation for AT	( / Server / Te	lecom PS
• Q <sub>G(tot)</sub> = 73	3 nC (Typ.) @ V <sub>GS</sub> = 10 V • Battery Protection Cir			
Low Miller			Power Supplie	s
• Low Q <sub>rr</sub> Bo	-			
	ability (Single Pulse and Repetitive Pulse)			
Formerly deve	elopmental type 82680			
G	<sup>D</sup> <sub>S</sub> TO-220 <sup>D</sup> <sub>S</sub> D <sup>2</sup> -PAK	GO		)
MOSFE		GO	SOANOSAO	)
	G S D <sup>2</sup> -PAK		60AN08A0 60AN08A0	Unit
MOSFE <sup>-</sup> Symbol	$\frac{1}{1000} \frac{1}{1000} \frac{1}{1000$		60AN08A0 75	V
MOSFE Symbol	To-220 $D^2$ -PAK To-220 $D^2$ -PAK T Maximum Ratings $T_C = 25^{\circ}C$ unless otherwise noted Parameter Drain to Source Voltage Gate to Source Voltage		60AN08A0	
MOSFE Symbol	To-220 $D^2$ -PAK To-220 $D^2$ -PAK T Maximum Ratings $T_C = 25^{\circ}C$ unless otherwise noted Parameter Drain to Source Voltage Gate to Source Voltage Drain Current		60AN08A0 75	V
MOSFE Symbol	To-220 $D^2$ -PAK <b>T Maximum Ratings</b> $T_C = 25^{\circ}C$ unless otherwise noted Parameter Drain to Source Voltage Gate to Source Voltage Drain Current Continuous ( $T_C < 127^{\circ}C$ , $V_{GS} = 10V$ )		60AN08A0 75 ±20	V
MOSFE Symbol	To-220 $D^2$ -PAK To-220 $D^2$ -PAK T Maximum Ratings $T_C = 25^{\circ}C$ unless otherwise noted Parameter Drain to Source Voltage Gate to Source Voltage Drain Current	FDB0	<b>50AN08A0</b> 75 ±20 80	V V A
MOSFE Symbol V <sub>DSS</sub> V <sub>GS</sub>	$\begin{tabular}{lllllllllllllllllllllllllllllllllll$	FDB0	60AN08A0 75 ±20 80 16	V V A A
MOSFE Symbol V <sub>DSS</sub> V <sub>GS</sub>	To-220 $D^2$ -PAK $D^2$ -PAK D	FDB0	50AN08A0 75 ±20 80 16 gure 4 350 255	V V A A A M J W
MOSFE Symbol V <sub>DSS</sub> V <sub>GS</sub> I <sub>D</sub> E <sub>AS</sub> P <sub>D</sub>	$\begin{array}{c} \textbf{J}_{\text{3D}} \textbf{J}_{\text{5}} \textbf{J}_{\text{7}} \textbf{J}_{\text{7}$	FDB0	50AN08A0 75 ±20 80 16 gure 4 350 255 1.7	V V A A A M J W W W/°C
MOSFE Symbol V <sub>DSS</sub> V <sub>GS</sub> I <sub>D</sub> E <sub>AS</sub> P <sub>D</sub> T <sub>J</sub> , T <sub>STG</sub>	$\begin{array}{c} \hline & & & & & \\ \hline & & & & \\ \hline & & & & \\ \hline \hline & & & \\ \hline \hline & & & \\ \hline$	FDB0	50AN08A0 75 ±20 80 16 gure 4 350 255	V V A A A M J W
MOSFE Symbol V <sub>DSS</sub> V <sub>GS</sub> I <sub>D</sub> E <sub>AS</sub> P <sub>D</sub> T <sub>J</sub> , T <sub>STG</sub>	$\begin{array}{c} \textbf{J}_{\text{3D}} \textbf{J}_{\text{5}} \textbf{J}_{\text{7}} \textbf{J}_{\text{7}$	FDB0	50AN08A0 75 ±20 80 16 gure 4 350 255 1.7	V V A A M M W W/ <sup>o</sup> C <sup>o</sup> C
MOSFE Symbol $V_{DSS}$ $V_{GS}$ $I_D$ $E_{AS}$ $P_D$ $T_J, T_{STG}$ Thermal $R_{\theta JC}$	$\begin{array}{c} \hline & & & & & & & & & & & & & & & & & & $	FDB0	50AN08A0 75 ±20 80 16 gure 4 350 255 1.7	V V A A A M J W W W/°C
MOSFE Symbol V <sub>DSS</sub> V <sub>GS</sub> I <sub>D</sub> E <sub>AS</sub> P <sub>D</sub> T <sub>J</sub> , T <sub>STG</sub>	$\begin{array}{c} \hline & & & & & & & & \\ \hline & & & & & & & \\ \hline & & & &$	FDB0	50AN08A0 75 ±20 80 16 gure 4 350 255 1.7 to 175	V V A A M M M W W/°C °C

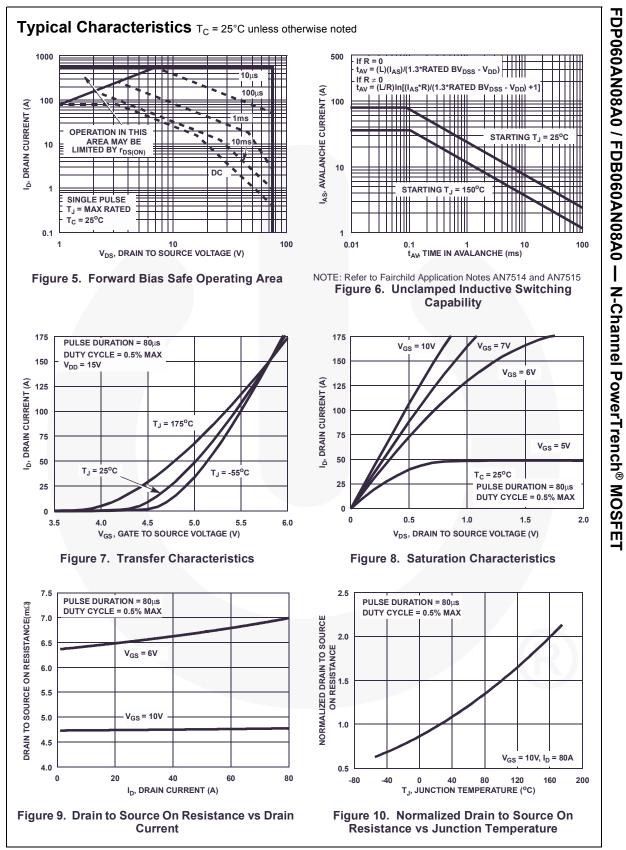
FDP060AN08A0 / FDB060AN08A0 — N-Channel PowerTrench® MOSFET

FAIRCHILD

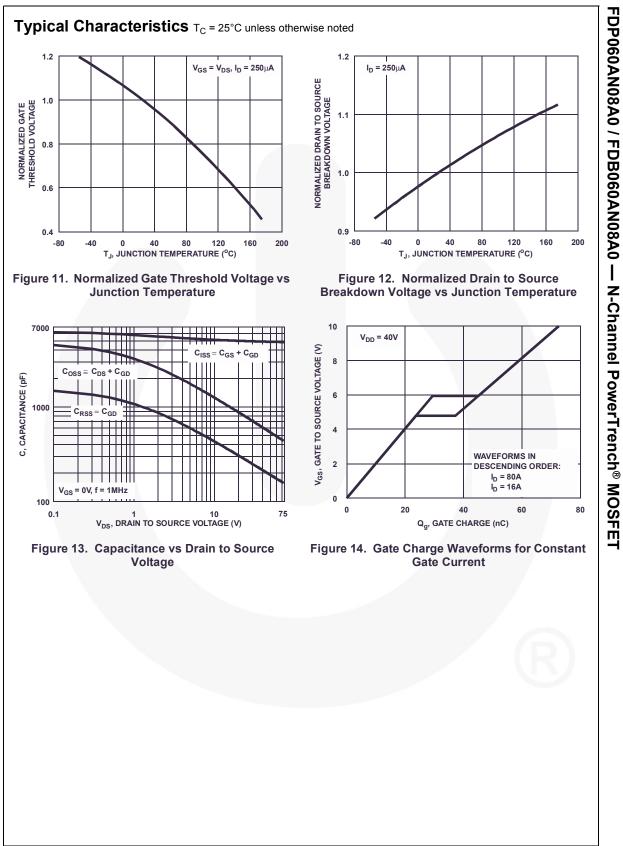
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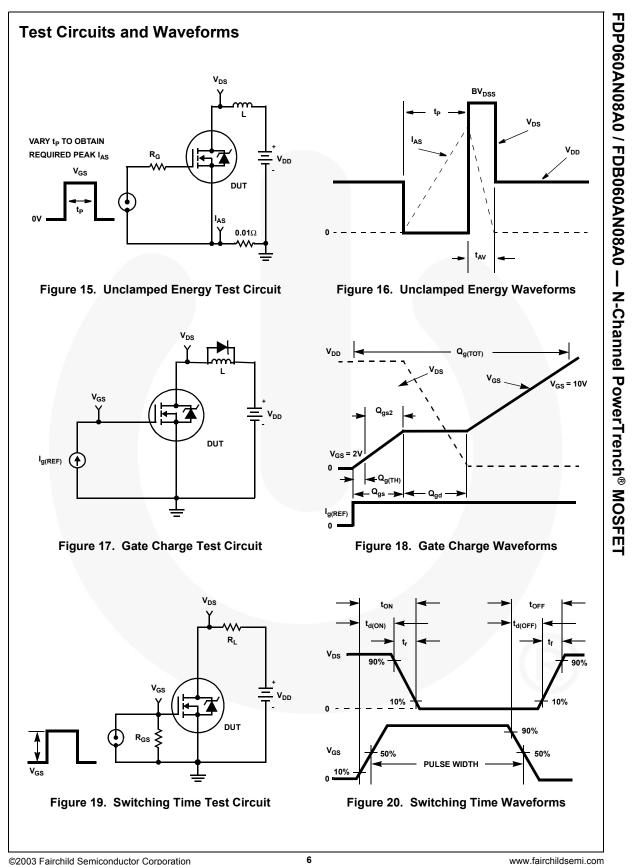
Device Marking FDB060AN08A0		Device	Package Reel Size		Tape Width		Quantity		
		FDB060AN08A0	D <sup>2</sup> -PAK	330 mm	24 mm		800 units		
	FDP060AN08A0 FDP060AN08A0		TO-220 Tube		N/A		50 units		
Electric Symbol	al Char	Acteristics T <sub>C</sub> = 25°C		e noted	Min	Тур	Мах	Unit	
			Test c	onutions	IVIIII	тур	IVIAA	Unit	
Off Char	acteristic	S							
B <sub>VDSS</sub>	Drain to S	Source Breakdown Voltage	I <sub>D</sub> = 250μA, V	<sub>GS</sub> = 0V	75	-	-	V	
I <sub>DSS</sub>	Zero Gate Voltage Drain Current		$V_{DS} = 60V$		-	-	1	μA	
			$V_{GS} = 0V$	T <sub>C</sub> = 150 <sup>o</sup> C	-	-	250		
I <sub>GSS</sub>	Gate to S	ource Leakage Current	V <sub>GS</sub> = ±20V	_	-	-	±100	nA	
On Char	acteristic	S							
V <sub>GS(TH)</sub>	Gate to S	ource Threshold Voltage	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub>	= 250μA	2	-	4	V	
r <sub>DS(ON)</sub>			$I_{\rm D} = 80$ A, $V_{\rm GS}$		-	0.0048	0.006	+	
	Drain to C	Course On Desistence	$I_D = 40A, V_{GS}$		-	0.0066	0.010	0	
	Drain to Source On Resistance		$I_D = 80A, V_{GS} = 10V,$ T <sub>1</sub> = 175°C		-	0.010	0.013	Ω	
Dynamic	Characte	eristics				1			
	Input Cap			_	-	5150	-	pF	
C <sub>ISS</sub>		apacitance	V <sub>DS</sub> = 25V, V	<sub>GS</sub> = 0V,	-	800	-	pF	
C <sub>OSS</sub>		Fransfer Capacitance	f = 1MHz		-	230	-	pF	
C <sub>RSS</sub> Q <sub>g(TOT)</sub>		e Charge at 10V	V <sub>GS</sub> = 0V to 1	01/	_	73	95	nC	
$Q_{g(TH)}$		Gate Charge		V V <sub>DD</sub> = 40V	-	10	13	nC	
$Q_{qs}$		ource Gate Charge	VGS OV 10 Z	I <sub>D</sub> = 80A	-	29	-	nC	
Q <sub>gs2</sub>		rge Threshold to Plateau		$I_{g} = 1.0 \text{mA}$	-	19	-	nC	
Q <sub>gd</sub>		rain "Miller" Charge	7	9	-	16	-	nC	
		teristics (V <sub>GS</sub> = 10V)							
t <sub>on</sub>	Turn-On T				-	-	147	ns	
t <sub>d(ON)</sub>	Turn-On Delay Time				-	19	-	ns	
t <sub>r</sub>	Rise Time	)	V <sub>DD</sub> = 40V, I <sub>D</sub>	$V_{DD}$ = 40V, I <sub>D</sub> = 80A V <sub>GS</sub> = 10V, R <sub>GS</sub> = 3.9Ω		79	- /	ns	
t <sub>d(OFF)</sub>	Turn-Off E	Delay Time				37	-	ns	
t <sub>f</sub>	Fall Time				-	38	/ -	ns	
t <sub>OFF</sub>	Turn-Off T	īme				-	113	ns	
	ource Diod	de Characteristics					1		
V <sub>SD</sub>	Source to Drain Diode Voltage		I <sub>SD</sub> = 80A		- /	-	1.25	V	
			$I_{SD} = 40A$		-	-	1.0	V	
t <sub>rr</sub>	Reverse F	Recovery Time		<sub>SD</sub> /dt = 100A/µs	-	-	37	ns	
Q <sub>RR</sub>		Recovered Charge	$I_{SD} = 75A, dI_{SD}/dt = 100A/\mu s$		-	-	38	nC	





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#### Thermal Resistance vs. Mounting Pad Area

The maximum rated junction temperature,  $T_{JM}$ , and the thermal resistance of the heat dissipating path determines the maximum allowable device power dissipation,  $P_{DM}$ , in an application. Therefore the application's ambient temperature,  $T_A$  (°C), and thermal resistance  $R_{\theta JA}$  (°C/W) must be reviewed to ensure that  $T_{JM}$  is never exceeded. Equation 1 mathematically represents the relationship and serves as the basis for establishing the rating of the part.

$$P_{DM} = \frac{(T_{JM} - T_A)}{R_{\theta JA}}$$
(EQ. 1)

In using surface mount devices such as the TO-263 package, the environment in which it is applied will have a significant influence on the part's current and maximum power dissipation ratings. Precise determination of  $\mathsf{P}_{\mathsf{DM}}$  is complex and influenced by many factors:

- Mounting pad area onto which the device is attached and whether there is copper on one side or both sides of the board.
- 2. The number of copper layers and the thickness of the board.
- 3. The use of external heat sinks.
- 4. The use of thermal vias.
- 5. Air flow and board orientation.
- 6. For non steady state applications, the pulse width, the duty cycle and the transient thermal response of the part, the board and the environment they are in.

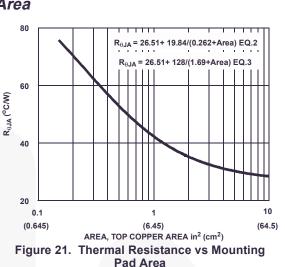
Fairchild provides thermal information to assist the designer's preliminary application evaluation. Figure 21 defines the  $R_{\theta,JA}$  for the device as a function of the top copper (component side) area. This is for a horizontally positioned FR-4 board with 1oz copper after 1000 seconds of steady state power with no air flow. This graph provides the necessary information for calculation of the steady state junction temperature or power dissipation. Pulse applications can be evaluated using the Fairchild device Spice thermal model or manually utilizing the normalized maximum transient thermal impedance curve.

Thermal resistances corresponding to other copper areas can be obtained from Figure 21 or by calculation using Equation 2 or 3. Equation 2 is used for copper area defined in inches square and equation 3 is for area in centimeters square. The area, in square inches or square centimeters is the top copper area including the gate and source pads.

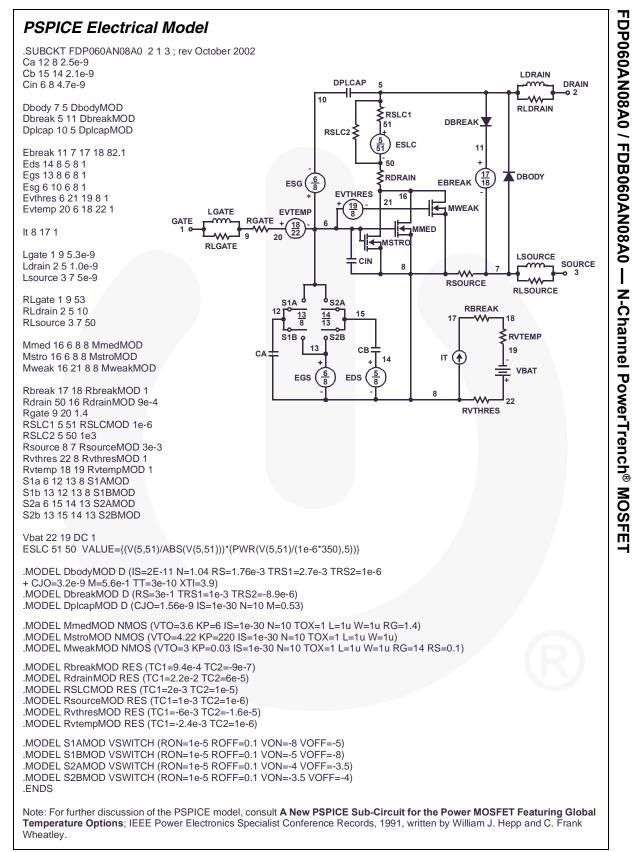
$$R_{\Theta JA} = 26.51 + \frac{19.84}{(0.262 + Area)}$$
(EQ. 2)

Area in Inches Squared

$$R_{\Theta JA} = 26.51 + \frac{128}{(1.69 + Area)}$$
(EQ. 3)  
Area in Centimeters Squared

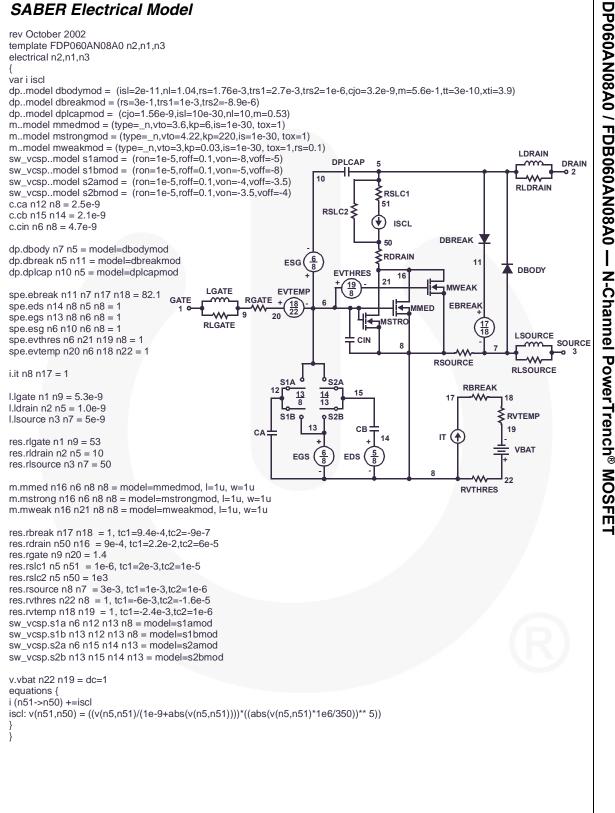


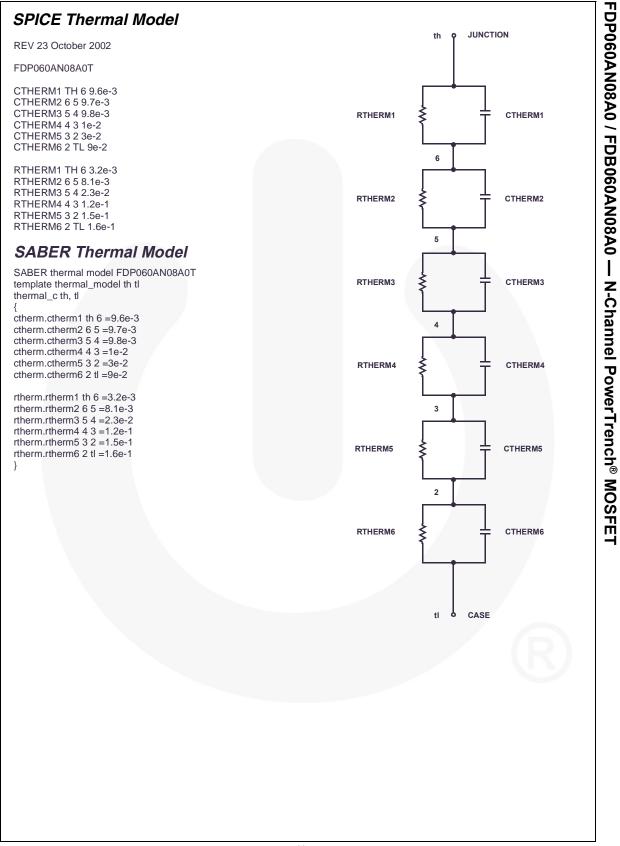
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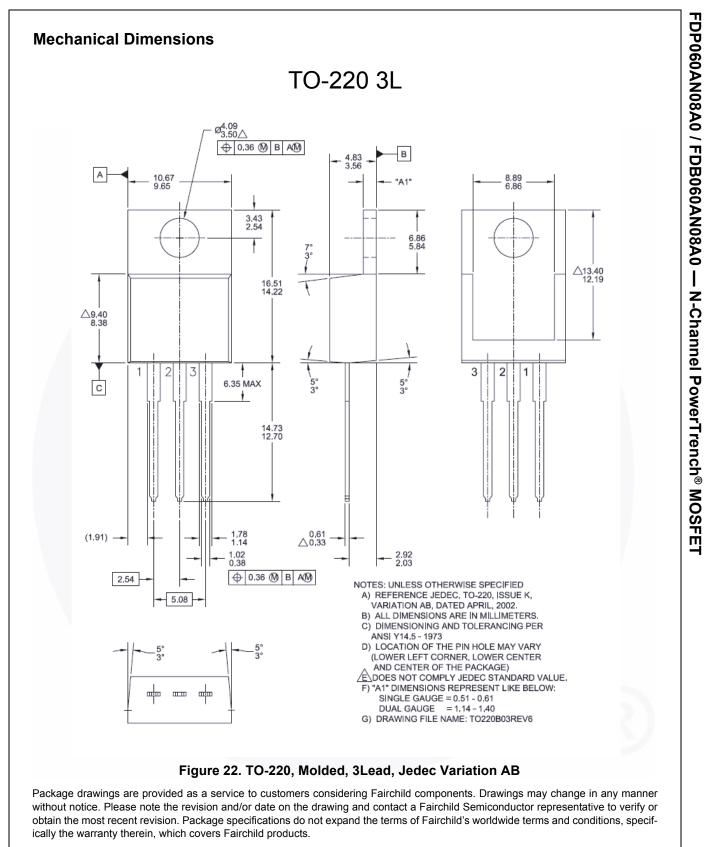


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### SABER Electrical Model



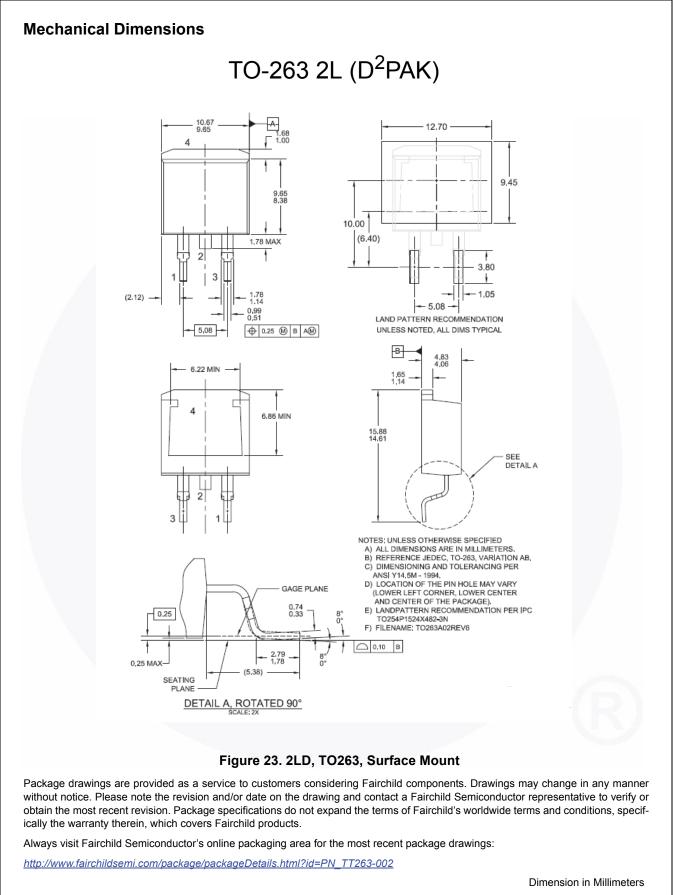




Always visit Fairchild Semiconductor's online packaging area for the most recent package drawings:

http://www.fairchildsemi.com/package/packageDetails.html?id=PN\_TT220-003

**Dimension in Millimeters** 





No Identification Needed

Obsolete

**Full Production** 

Not In Production

Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.

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Rev. 166

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